Notice of References Cited

Application/Control No. 10/511,936	Reexaminatio	Applicant(s)/Patent Under Reexamination RIENER ET AL.		
Examiner	Art Unit			
Banafsheh Hadizonooz	3714	Page 1 of 1		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0091845	05-2004	Azerad et al.	434/263
*	В	US-4,435,163	03-1984	Schmitt et al.	434/263
	O	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	H	US-			
	1	US-			
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	Κ	US-			
	L	US-			
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FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

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